

TARDIS

Time and Remanence Decay in SRAM to Implement Secure Protocols on Embedded Devices without Clocks

Amir Rahmati¹, Mastooreh Salajegheh¹, Dan Holcomb², Jacob Sorber³, Wayne Burleson¹, Kevin Fu¹

I UMass Amherst 2 UC Berkeley, 3 Dartmouth College



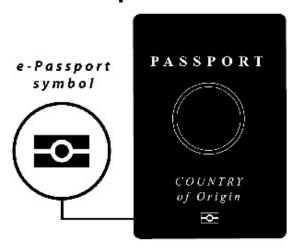




Batteryless Devices



Transportation



Passports



Payment



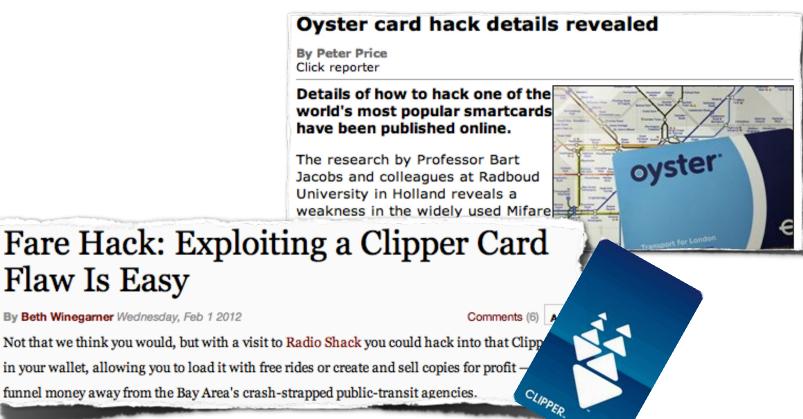
Employee

Batteryless Devices



Photo Credit: digboston.com, mobileedgeblog.com, dhs.gov, vanntel.com

Security Vulnerabilities

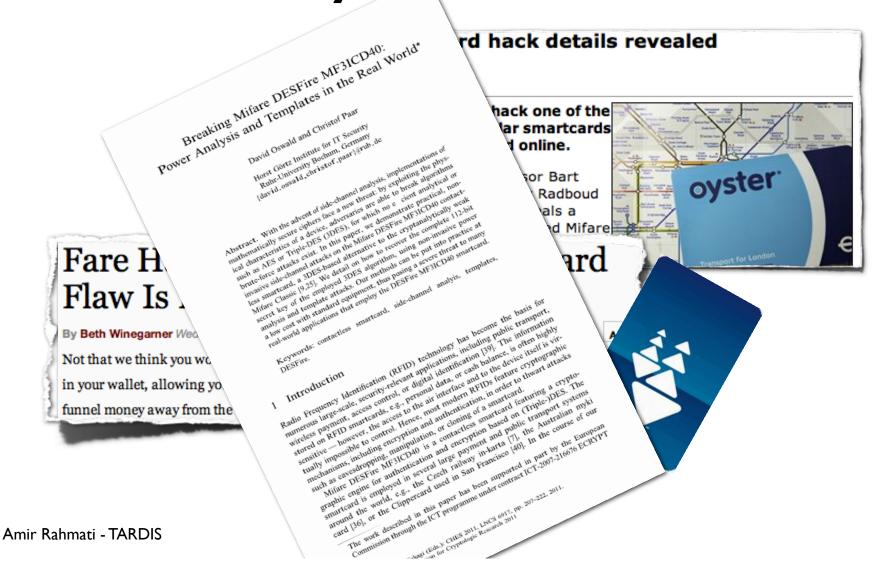


By Beth Winegarner Wednesday, Feb 1 2012

Flaw Is Easy

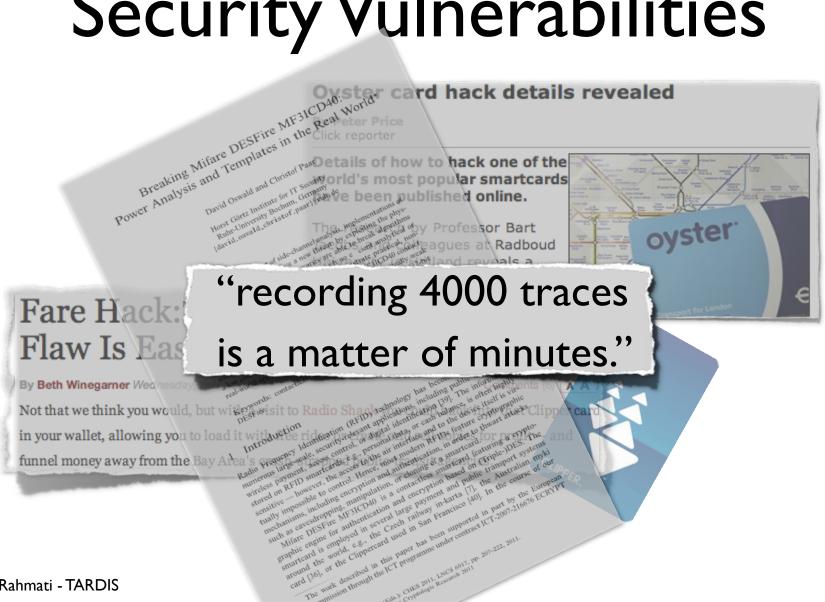
Not that we think you would, but with a visit to Radio Shack you could hack into that Clipp in your wallet, allowing you to load it with free rides or create and sell copies for profit funnel money away from the Bay Area's crash-strapped public-transit agencies.

Security Vulnerabilities

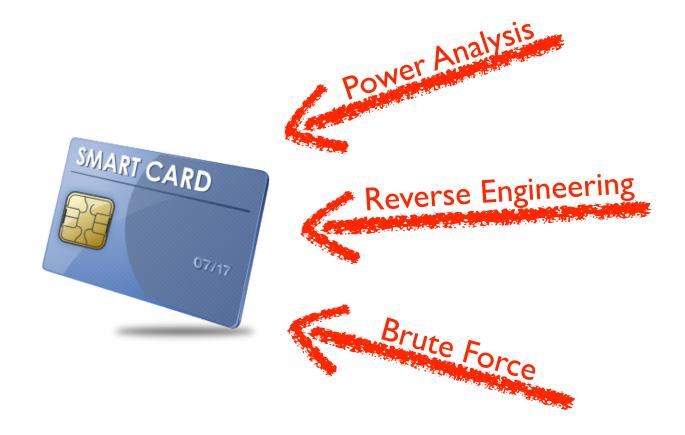


3

Security Vulnerabilities

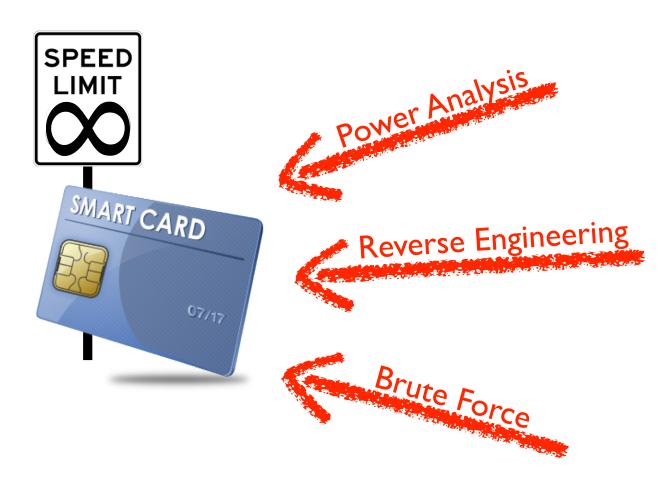


Smart Card Threats



Amir Rahmati - TARDIS

Smart Card Threats



Amir Rahmati - TARDIS

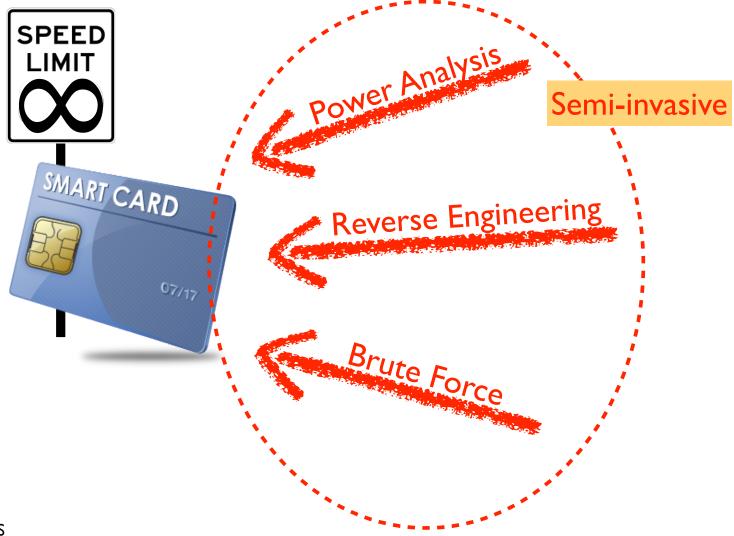


Photo Credit: landlsoft.com

Amir Rahmati - TARDIS

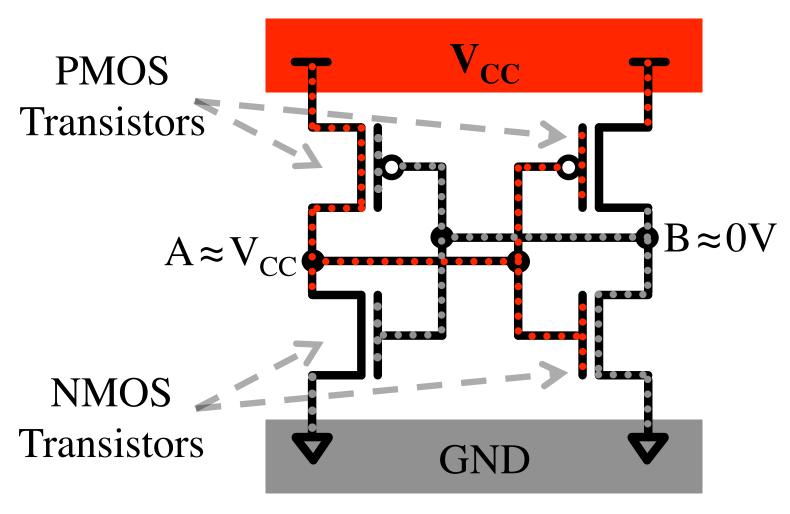
Vulnerable to Brute Force Attacks

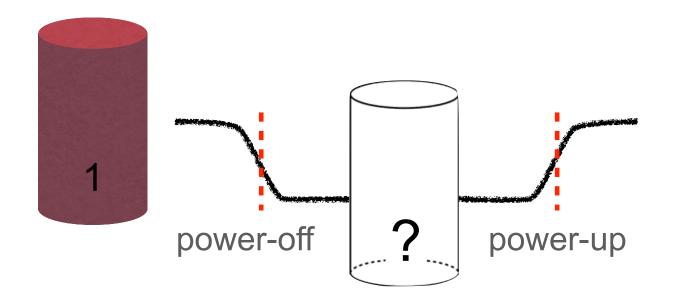
Device	#Queries	Time
UHF RFID Tags[Shamir'07]	200	2 Seconds
MIFARE Classic[Garcia'09]	1,500	16 Seconds
Digital Signal Transponder[Bono'05]	75,000	I Hour
MIFARE DESFire[Paar'II]	250,000	7 Hours
GSM SIM Cards[Goldberg'99]	150,000	8 Hours

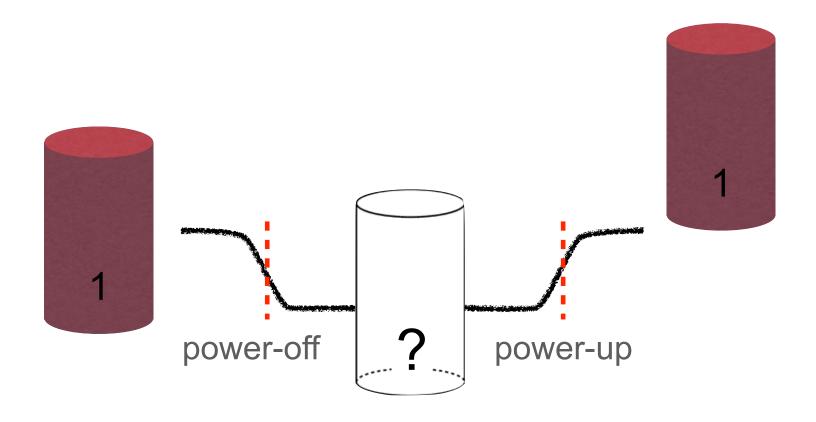


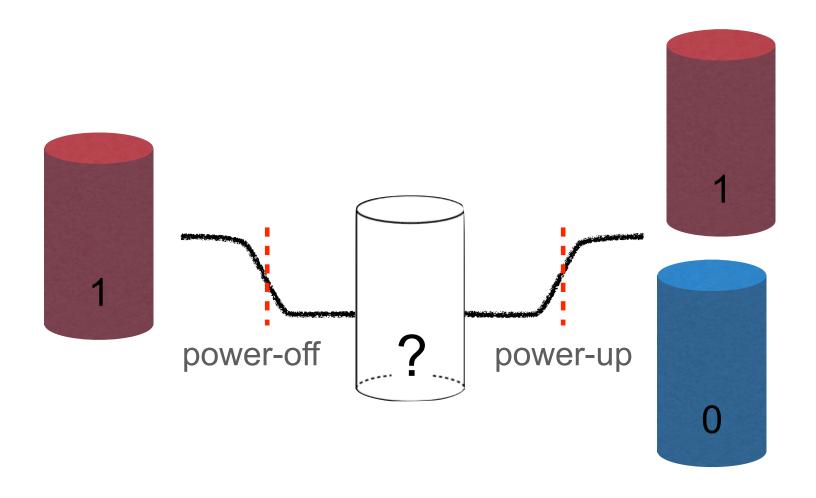
Our Contribution: TARDIS

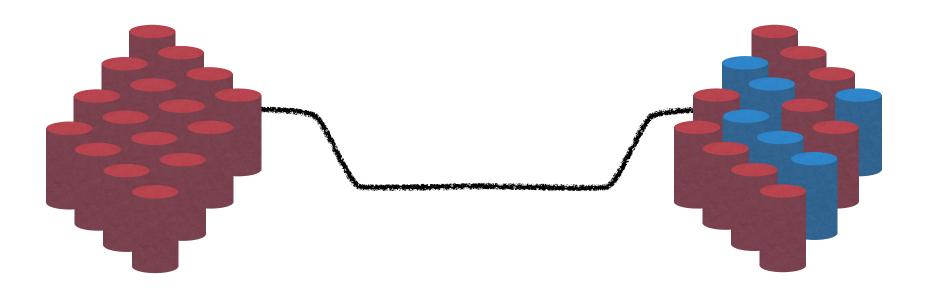
A time-keeping technique based on SRAM decay

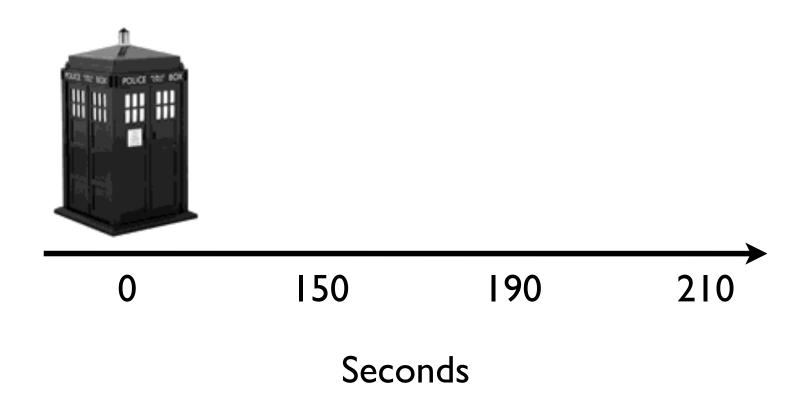


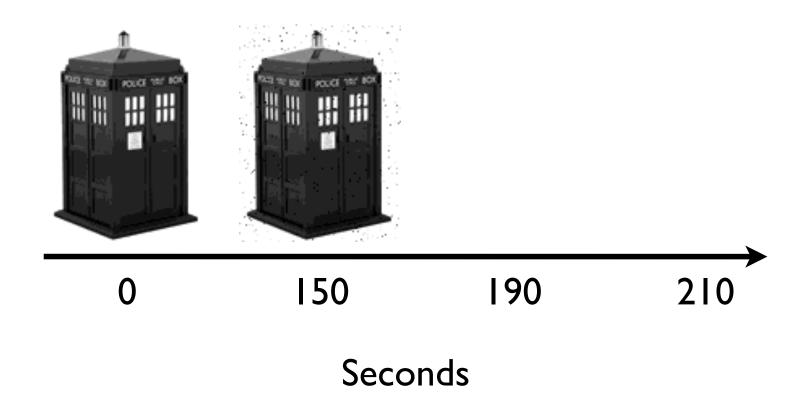


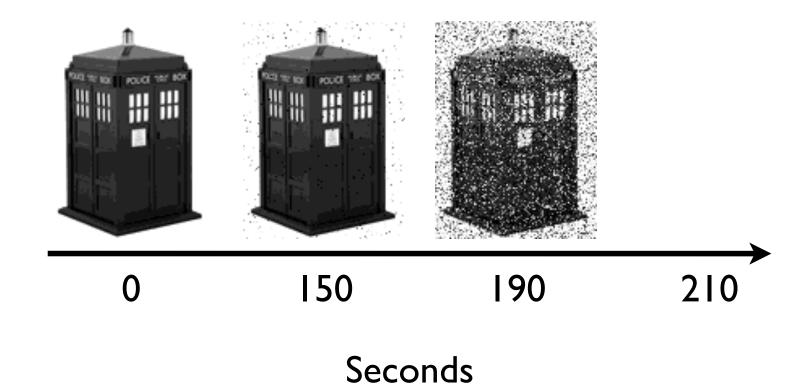


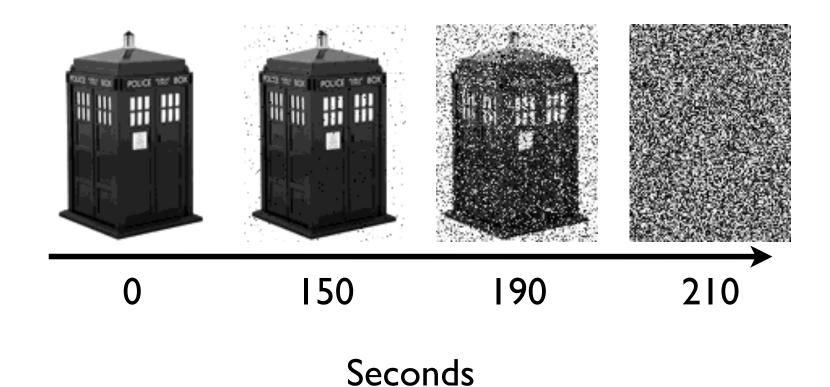


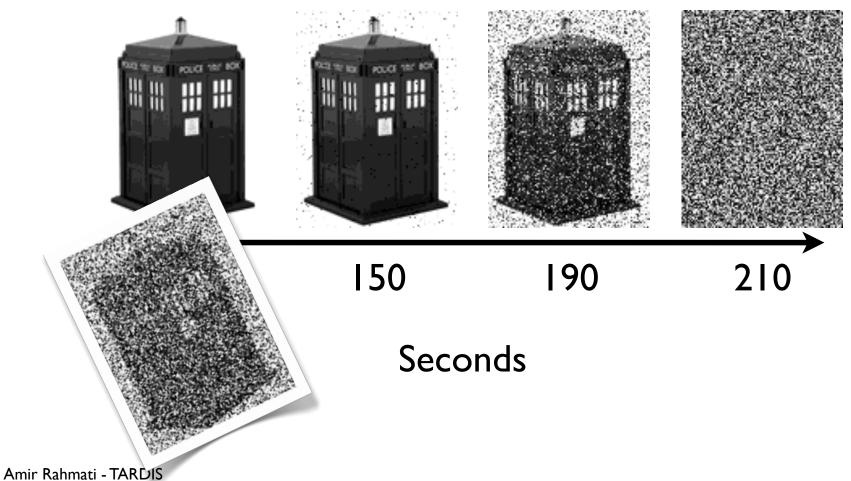


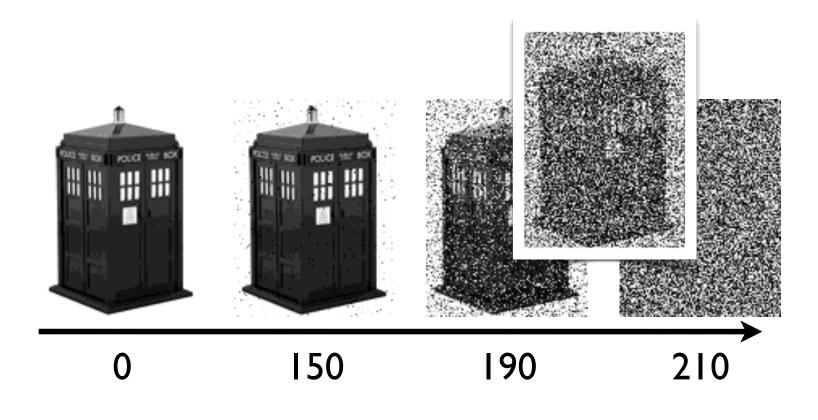






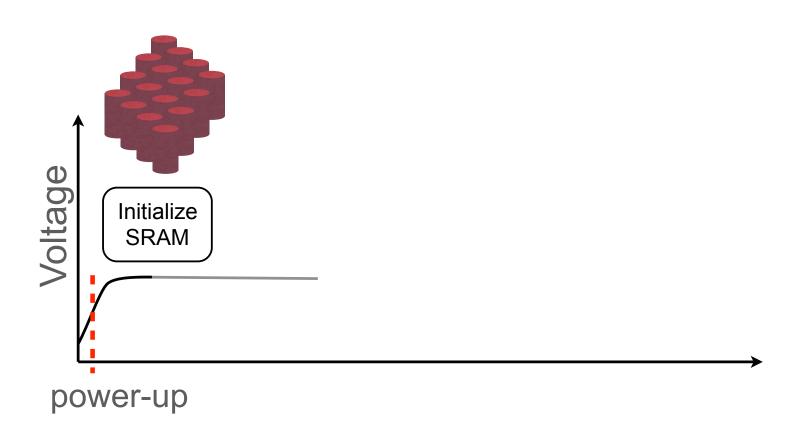


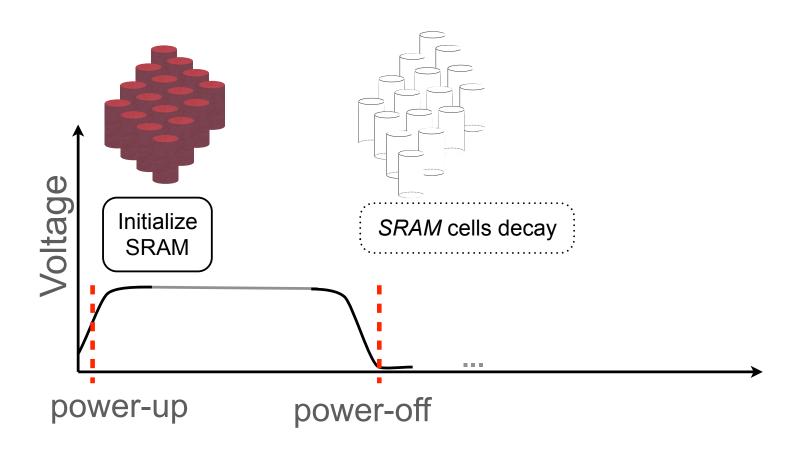


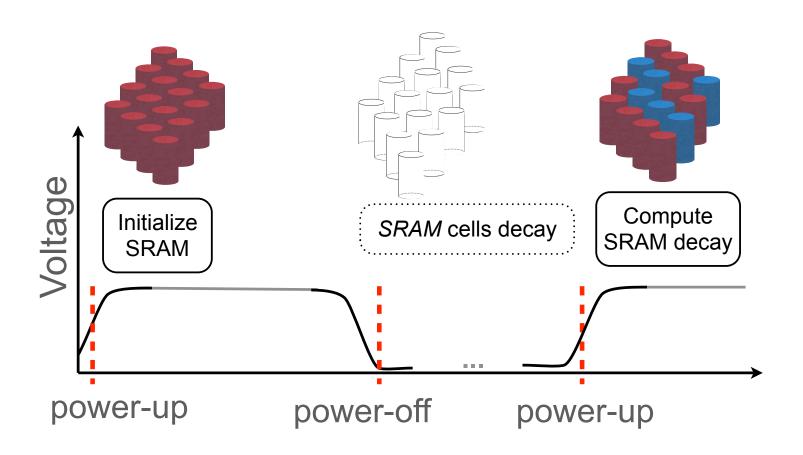


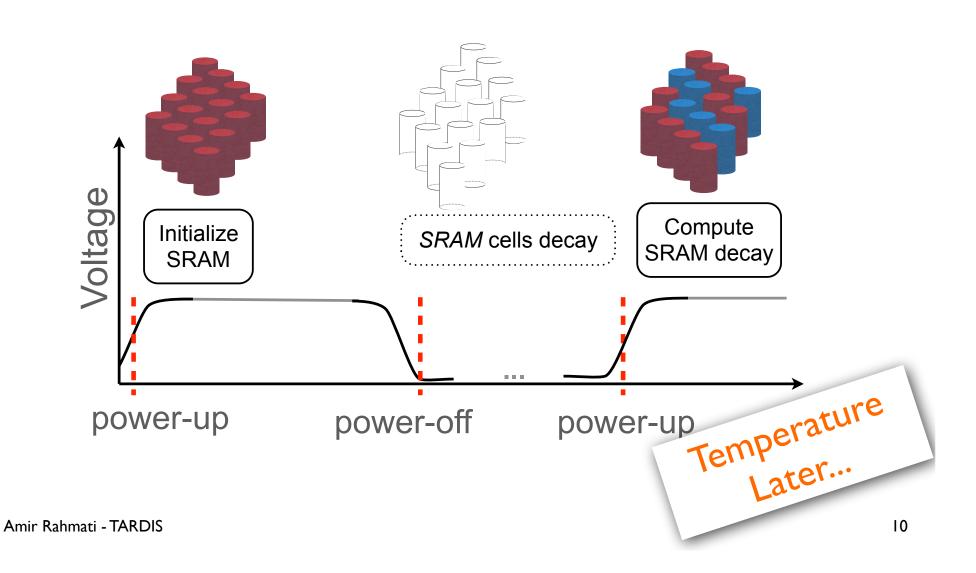
Seconds







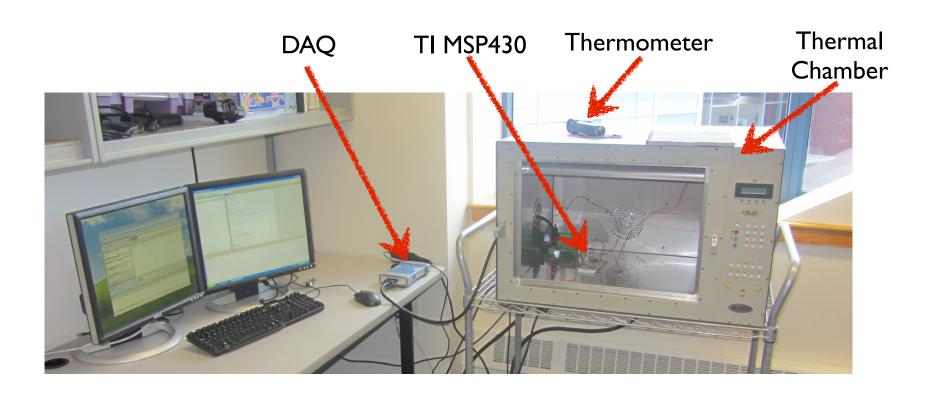


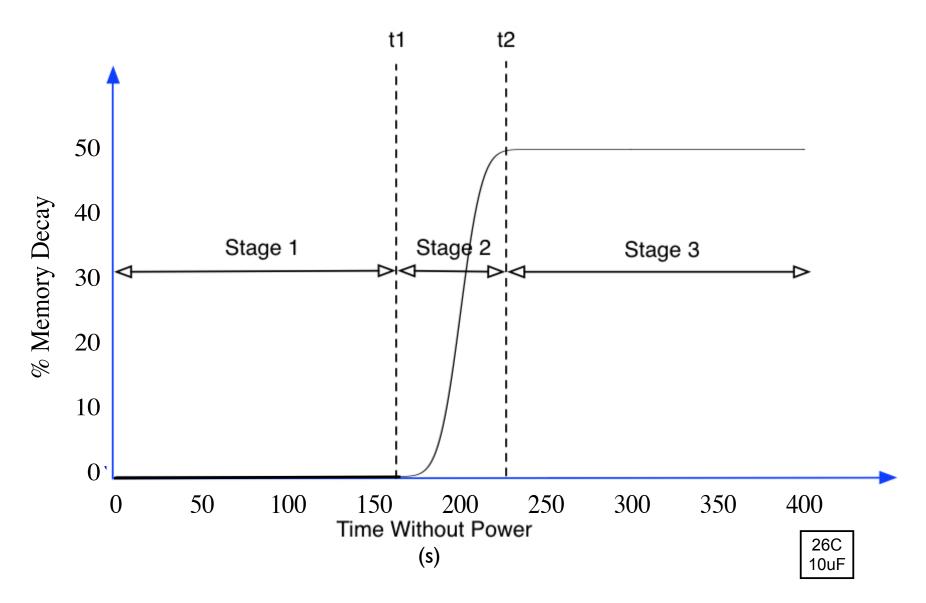


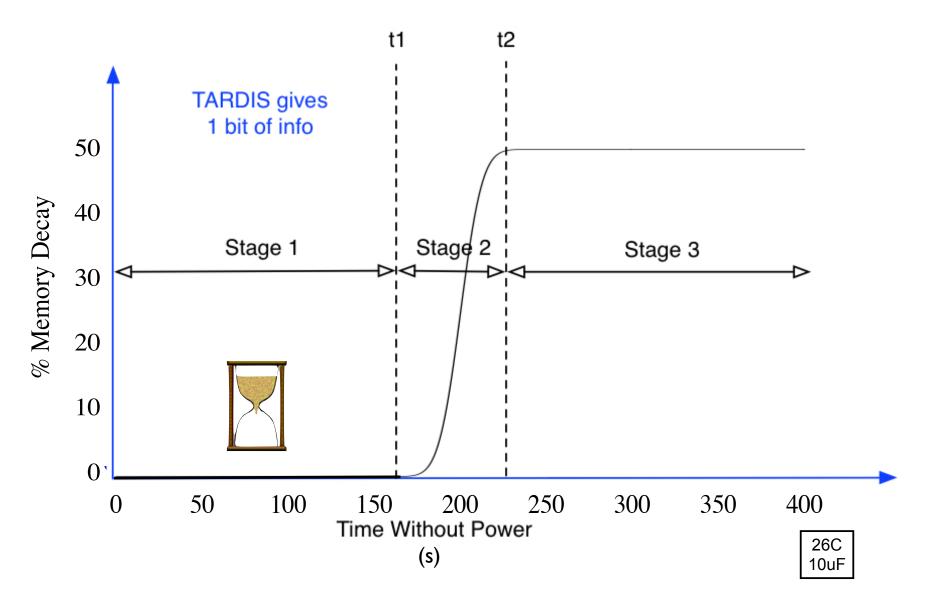
Factors Influencing SRAM Decay

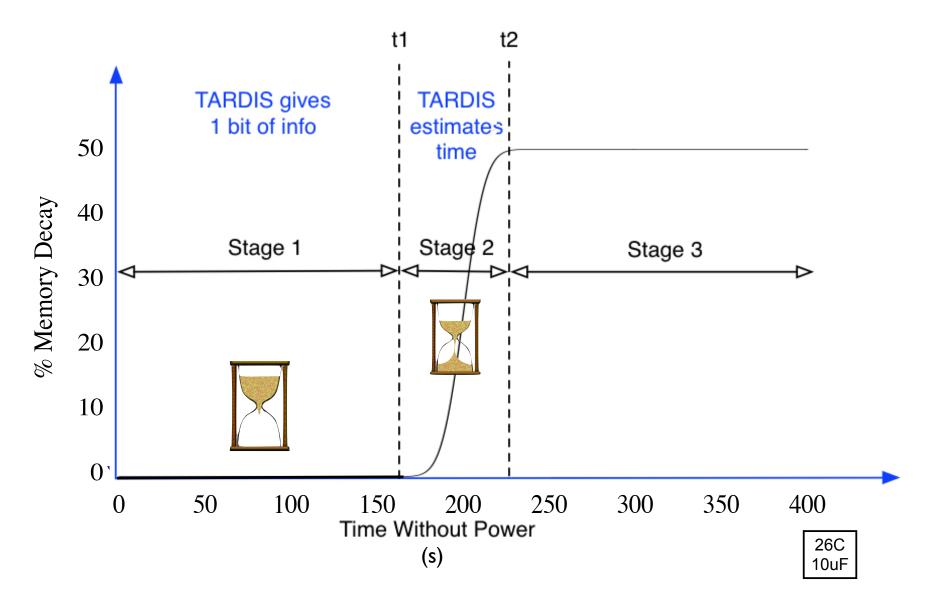
- √ SRAM Size
- √ Circuit Capacitance
- √ Temperature
- X Chip Variation

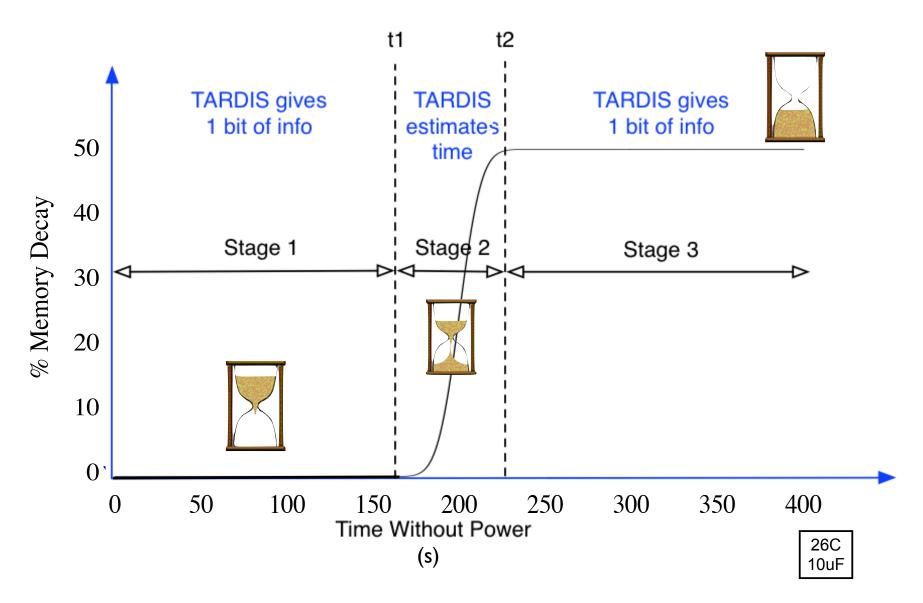
Experimental Setup











Circuit Capacitnce



Capacitor Size	Expiration time	Scale
~0µF	2.1×10 ⁰ s	Seconds
Ι0μϜ	2.25×10^{2} s	Minutes
I00μF	1.98×10 ³ s	I/2 Hour
Ι000μF	2.12×10 ⁴ s	Hours
10000μF	>1.96×10 ⁵ s	Days

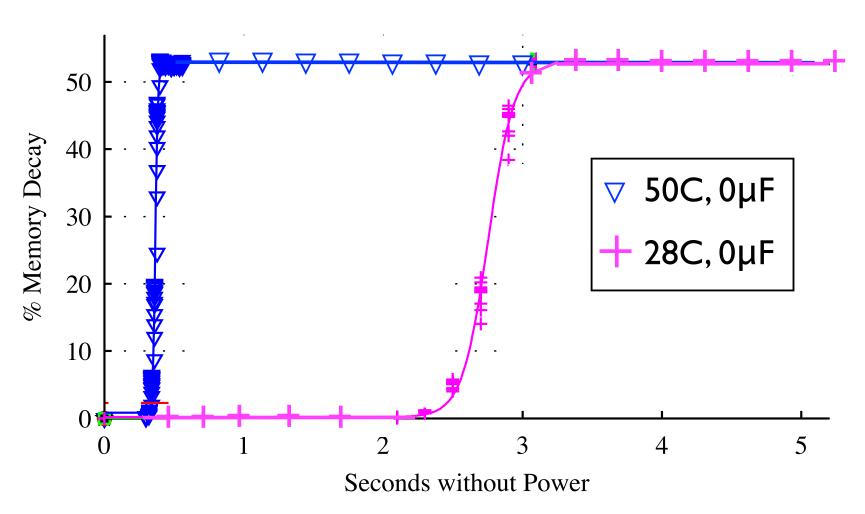
Circuit Capacitnce

	The state of the s	
	- M	= 4
		5
	ar 0001 ar	1000
		= <u>*</u>
PL	100001	<u>∞</u> ≡0πF
	NI D	

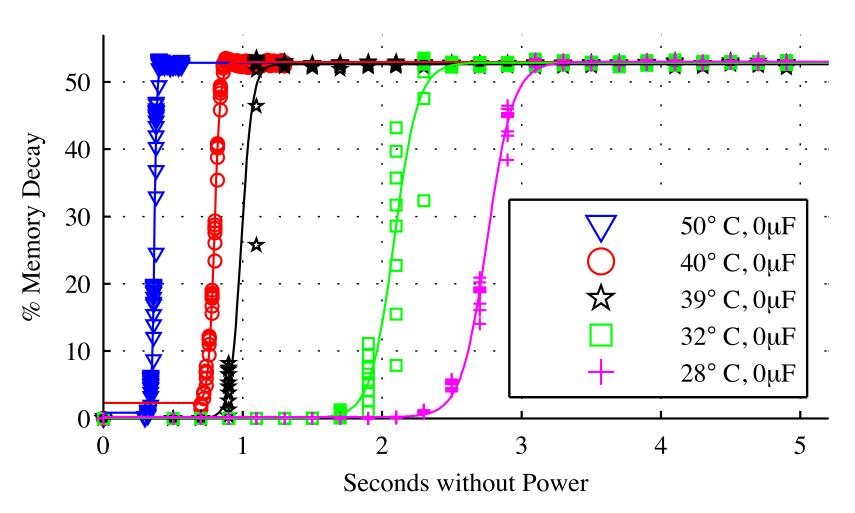
Capacitor Size	Expiration time	Scale	
~0µF	2.1×10 ⁰ s	Seconds	Cond
I0μF	2.25×10^{2} s	Minutes	t Cards
I00μF	1.98×10 ³ s	I/2 Hour	
Ι000μF	2.12×10 ⁴ s	Hours	
Ι0000μϜ	>1.96×10 ⁵ s	Days	

Batteryless Sensor = $100,000\mu$ F

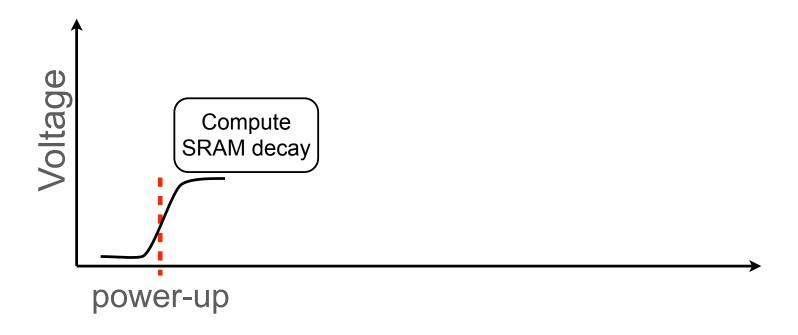
Temperature

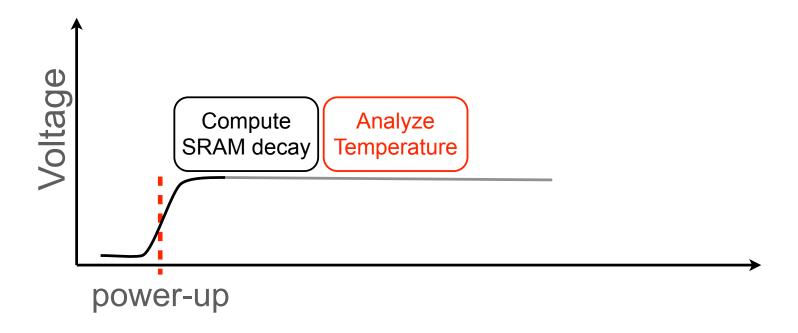


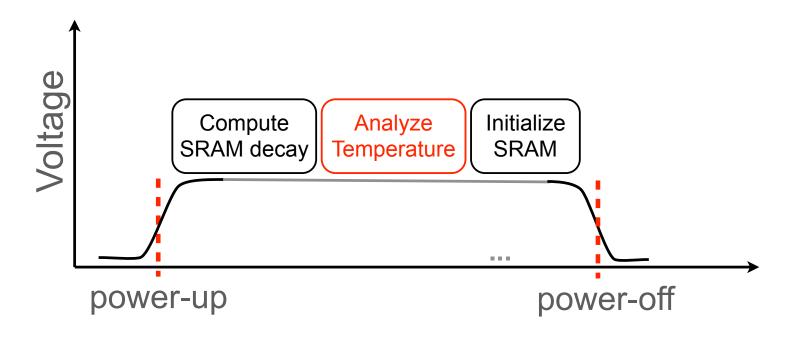
Temperature



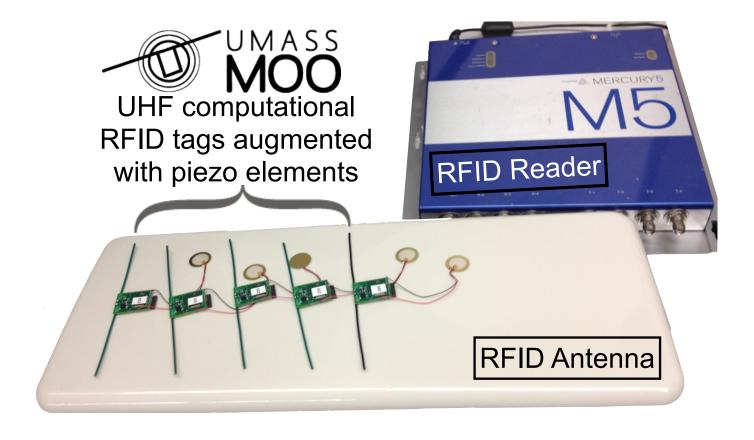




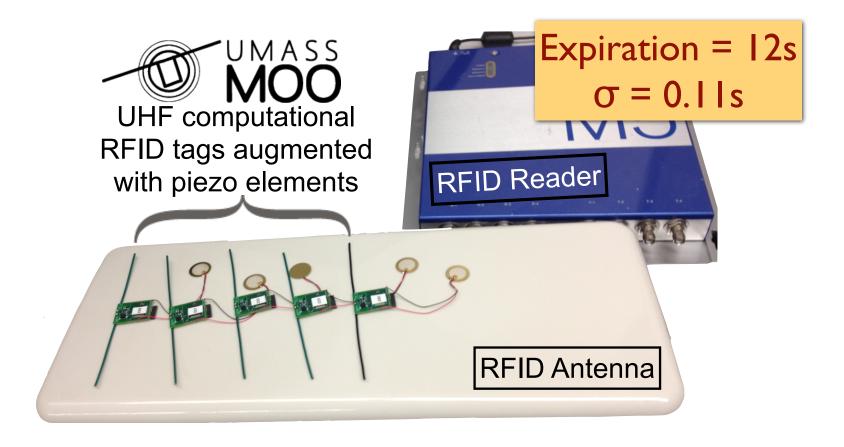




Implementation



Implementation



The Effect of TARDIS*

Device	#Queries	Time
UHF RFID Tags[Shamir'07]	200	2 Seconds
MIFARE Classic[Garcia'09]	1,500	16 Seconds
Digital Signal Transponder[Bono'05]	75,000	I Hour
MIFARE DESFire[Paar'll]	250,000	7 Hours
GSM SIM Cards[Goldberg'99]	150,000	8 Hours

The Effect of TARDIS*

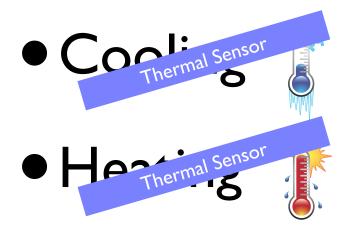
Device	#Queries	W/O TARDIS	W/TARDIS
UHF RFID Tags	200	2 Seconds	40 Minutes
MIFARE Classic	1,500	16 Seconds	5 Hours
Digital Signal Transponder	75,000	l Hour	10 Day
MIFARE DESFire	250,000	7 Hours	35 Days
GSM SIM Cards	150,000	8 Hours	21 Days

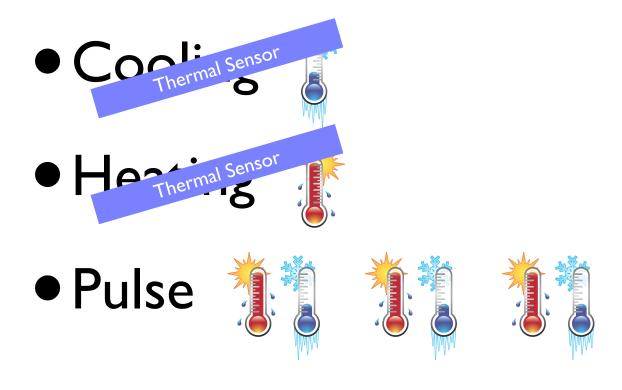
^{*} Assuming a 12 seconds TARDIS

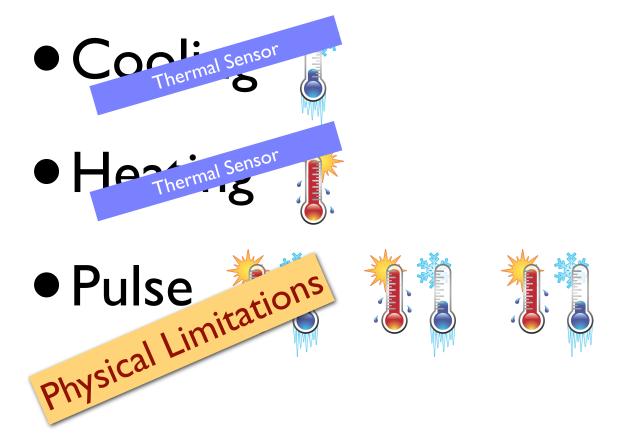
CoolingHeating



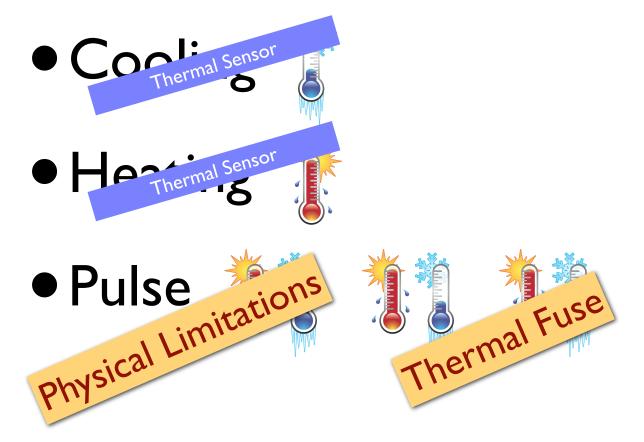








Amir Rahmati - TARDIS



Amir Rahmati - TARDIS

Other Applications

- Time out in authentication protocols
- Temporary ownership (Resurrecting Duckling)
- RTC replacement in low-power sensors
- E-passports [Avoine'08]
- Time released cryptography [May'93,Rivest'96,May'01]

Related Work

Data Remanence in Volatile Memory

- Data retention in SRAM [Gutmann'01, Skorobogatov'02]
- FERNS [Holcomb'07]
- DRAM cold boot attack [Halderman'08]
- Background to data retention [Flautner'02]
- First proposed attacks [Anderson'96]
- SRAM attack [Taun'07]

Related Work Reliable Time

- Lamport Clock [Lamport'78]
- Use Multiple Sources of Time [Rousseau'01]

Conclusion



uses memory decay to estimate time.



makes brute force attacks orders of magnitude harder.



is just software.



uses remanence decay for good.

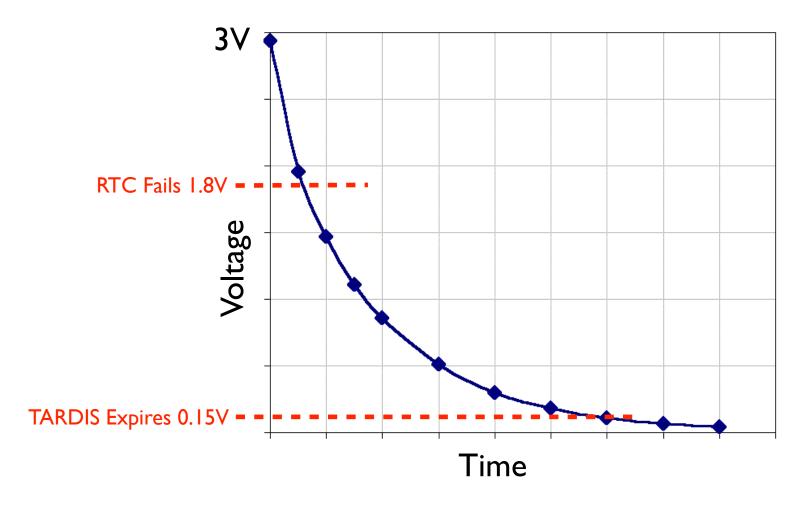


https://spqr.cs.umass.edu/tardis/

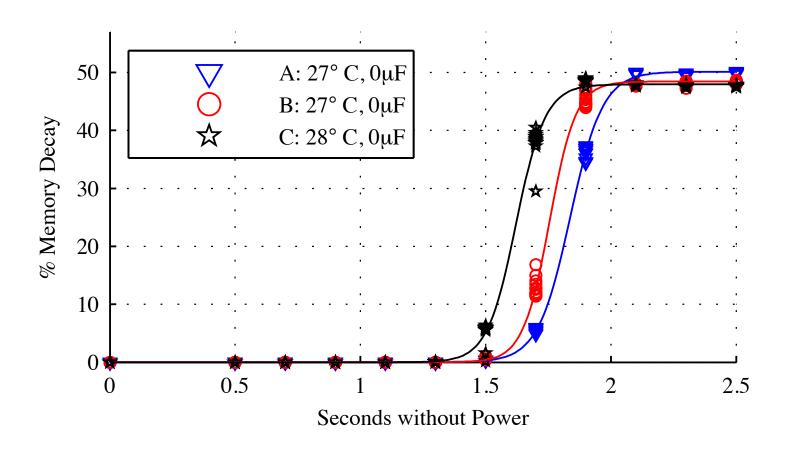


Amir Rahmati - TARDIS 25

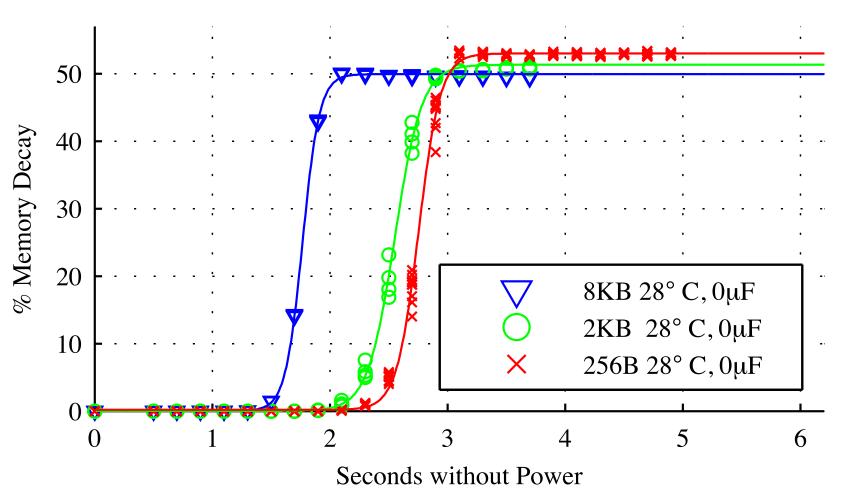
Capacitor Depletion



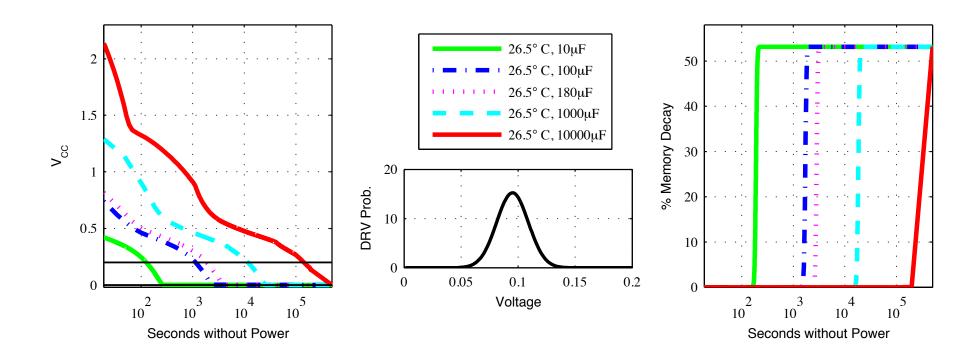
Chip Variation



SRAM Size

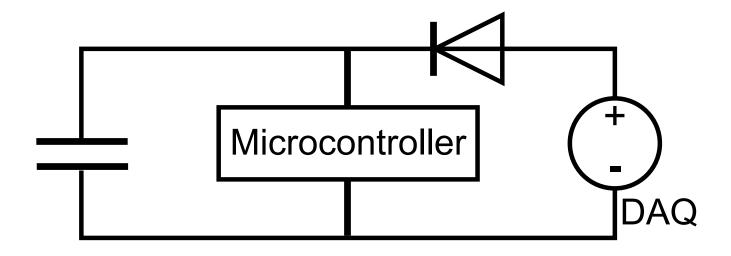


Capacitor Calculations

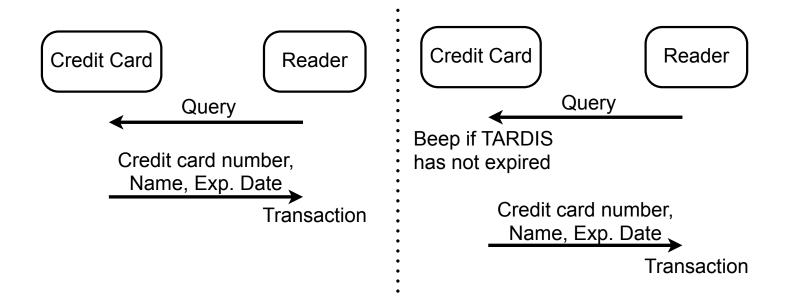


Amir Rahmati - TARDIS

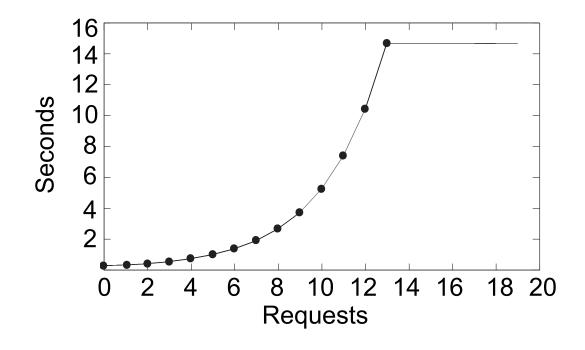
Our Circuit



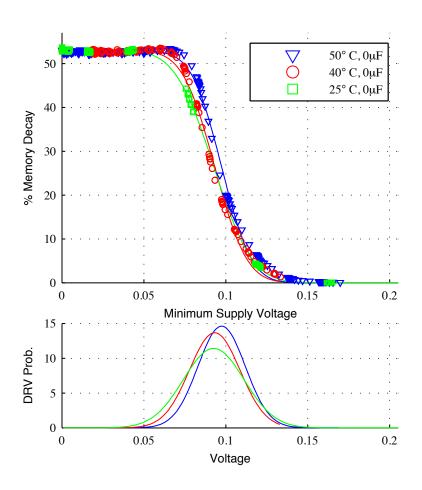
Squealing Cards



French Passports Counter



Remanence vs. Voltage



Voltage Regulators Effect

